

Error-mitigated data-driven circuit learning on noisy quantum hardware*

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Application-inspired benchmarks measure how well a quantum device performs meaningful calculations. In the case of parameterized circuit training, the computational task is the preparation of a target quantum state via optimization over a loss landscape. This is complicated by various sources of noise, fixed hardware connectivity, and for generative modeling, the choice of target distribution. Gradient-based training has become a useful benchmarking task for noisy intermediate scale quantum computers because of the additional requirement that the optimization step uses the quantum device to estimate the loss function gradient. In this work we use gradient-based data-driven circuit learning to benchmark the performance of several superconducting platform devices and present results that show how error mitigation can improve the training of quantum circuit Born machines with 28 tunable parameters.

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I. INTRODUCTION

The field of quantum machine learning covers a diverse range of topics, from utilizing quantum computing to speed up classical model training to using quantum circuits as analogues of classical models. Parameterized quantum circuits have become a popular approach to construct general trainable quantum models. These circuits can find use in state preparation for algorithms compatible with noisy intermediate scale quantum (NISQ) hardware. The training process for these circuits is similar to the variational quantum eigensolver, and it can be supervised, which has been used for classifiers [1, 2], unsupervised, and it can be used for generative models [3, 4].

In the absence of noise, circuits with few qubits and entangling layers are able to model general discrete and continuous distributions. However, realizing these modeling properties on current NISQ hardware faces a number of challenges. We previously presented results on generative learning as a benchmark for circuits deployed on a superconducting qubit system developed by IBM [5]. In the present work we further explore how the classical optimizer Adam [6] in concert with error mitigation can compensate for various sources of noise inherent in NISQ devices during circuit training, such as readout error and systematic error in two qubit gates. We show two approaches that apply error mitigation for state

preparation and measurement (SPAM) errors to quantum circuit Born machines (QCBMs). In the first case, we use error mitigation in post-processing to estimate the learned distribution, and use the mitigated values to calculate error-mitigated performance metrics such as the Kullback-Leibler (KL) divergence. In the second case, the error mitigation scheme runs alongside the optimizer at each training step, post-processing the results for the loss function gradient before passing it on to the optimizer for evaluation at the next training step. We tested two error mitigation schemes, one that characterizes and corrects for general readout error, and another method which characterizes the errors associated with the specific QCBM circuit under study. Both methods rely on constructing a correlation matrix of assignment errors, using this matrix as a characterization of the noise in a given device at one point in time, and relying on this characterization throughout the training of a circuit.

Combining the correlation matrix inversion with training, and with distribution and metric evaluation resulted in improved performance for three different output distributions on multiple hardware platforms. We constructed QCBM circuits to learn the Bars and Stripes distribution encoded on four qubits [3–5] and two Poisson distributions to demonstrate the capabilities and limitations of the error-mitigated learning scheme. Using the Qiskit programming library [7] we tested the benchmark on several quantum processor units (QPUs): the IBM Tokyo (`ibmq_20_tokyo`), Boeblingen (`ibmq_boeblingen`), and Valencia (`ibmq_valencia`) processors. The connectivity and error rates of each chip resulted in different levels of in metric performance, allowing us to use the benchmark as a point of comparison. In addition to metric performance, the degree to which error mitigation improves the metric can be used as a verification of the degree to which the errors present on the device are systematic and correctable. In comparison with other error mitigation schemes, such as Richardson extrapolation [2, 8, 9] or probabilistic cancellation [8], the matrix

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inversion method seeks to mitigate primarily readout errors, but it treats the entire circuit as a black box within which errors can occur at any point.

II. METHODS

Here we report on the training of several QCBM models using the general bi-layer parameterized circuit ansatz [3–5, 10] constructed with alternating layers of parameterized rotation gates (R_X and R_Z) and layers of two-qubit entangling gates (CNOTs). All circuits in this paper have 28 trainable parameters (single-qubit gates), but the number of CNOTs in each circuit is dependent on the entangling layer design as shown in Figure 1. Circuits with 2 CNOTs per layer are denoted $d_C = 2$, and circuits with 3 CNOTs per layer are denoted $d_C = 3$.

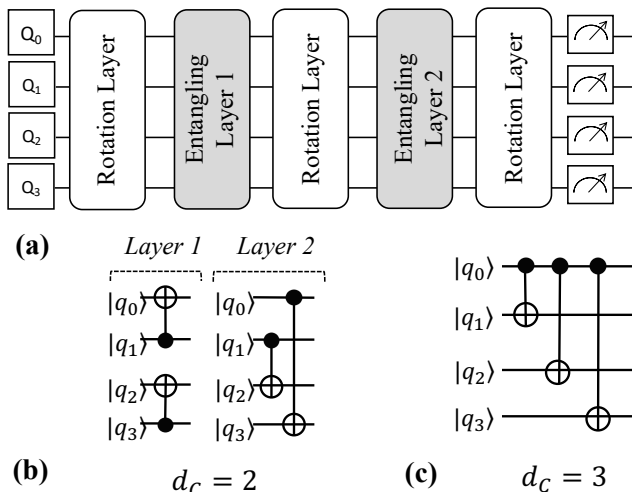


FIG. 1. (a) The basic bi-layer circuit ansatz for DDCL [3–5, 10, 11], (b) $d_C = 2$ entangling layer and (c) $d_C = 3$ entangling layer used previously in [5].

A. Error mitigation method

For a N -qubit circuit, we construct *assignment error matrices* (AEM): $2^N \times 2^N$ real-valued, non-negative matrices (\mathbb{K}_{kernel}) that are assumed to be invertible and *kernel* indicates one of 3 classes of AEM. The first class of AEM (\mathbb{K}_{\perp}) are trivial; they account for no noise, require no circuits be evaluated on the hardware and are simply the $2^N \times 2^N$ identity matrix $\mathbb{1}$.

The remaining 2 classes of AEM, *hw* and *circ* require hardware execution of 2^N quantum circuits. The entries $\mathbb{K}_{kernel}(i, j)$ denote the probability that a QPU preparing the target state i will measure state j . The diagonal entries $\mathbb{K}_{kernel}(i, i)$ are the probabilities that the target state is returned and off-diagonal elements $\mathbb{K}_{kernel}(i, j)$ are the probabilities that another state is returned. In

subsequent sections of the paper, the arguments i, j are omitted from labels when it is clear the entire matrix is used as a label or otherwise all elements are to be considered. Once executed the circuits are sampled at a shot size of $n_s = 4096$ which is sufficient to resolve readout errors and reduces statistical error. In [10] (Supp. Material) it is noted that assignment error correction assumes independent error, but correlated errors are possible (e.g. cross-resonance errors), thus any \mathbb{K} is executed on localized subsets of qubits. For the remainder of this paper we will restrict our choice of qubits to the specific subsets shown in Figures 2 and 3 which are used to construct \mathbb{K}_{kernel} and also to train the individual QCBM.

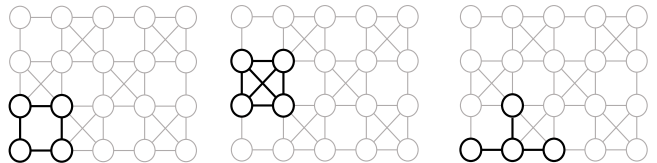


FIG. 2. Qubits used on `ibmq_20_tokyo`: (Left) P_A (Center) P_B (Right) T_1 .

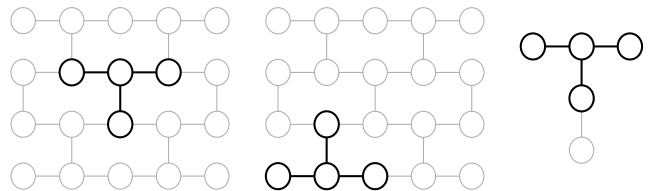


FIG. 3. Qubits used on: `ibmq_boeblingen` and `ibmq_valencia`. (Left) T_0 on `ibmq_boeblingen`, (Center) T_1 on `ibmq_boeblingen`, (Right) `ibmq_valencia` has only one unique tree layout where the root has degree 3.

AEM that mitigate readout gate errors are denoted (\mathbb{K}_{hw}). The $2^4 = 16$ shallow circuits used to construct \mathbb{K}_{hw} contain only un-parameterized X -rotation gates. The third class of AEM (\mathbb{K}_{circ}) are generated using the specific QCBM circuits (see Figure 1(a)) with the goal of mitigating not just readout gate errors, but also general errors from two-qubit gates and the parameterized single qubit gates. The rotational parameters needed for full reconstruction of the AEM are determined analytically and are dependent on the entangling layer gates. Further detail about the AEMs used in the main text are given in Appendix B.

When the final state prepared from a circuit is sampled, the counts returned in a state ($c(|x_i\rangle)$) are converted into probabilities using the shot size ($q_i = c(|x_i\rangle)/n_s$). Through error mitigation we remove erroneous counts in three steps. The vector of counts $c(\mathbf{x})$ is multiplied by an inverted AEM: ($c'(\mathbf{x}) = \mathbb{K}^{-1}c(\mathbf{x})$). Any negative counts are set to 0. The remaining counts are used to define an effective shot size n'_s which normalizes the *mitigated distribution* $q'(\mathbf{x}) = c'(\mathbf{x})/n'_s$.

If a circuit is not optimized for hardware deployment then compilation for hardware will add additional CNOT gates. In the main text we consider only circuits that can be compiled with the minimum number of CNOTS ($2d_C$). We consider the case of training a non-optimal circuit on hardware in Appendix A.

In Section III we only incorporate error mitigation into the KL metric evaluation. In Section IV error mitigation is incorporated into DDCL using an AEM and the resulting mitigated distributions are used to evaluate the loss and gradient of the loss in training. The AEM is generated once at the start of training, stored, and used throughout a DDCL workflow. Any time a state prepared by a circuit is sampled we define a mitigated distribution using the stored AEM.

B. Data-driven Circuit Learning

Data driven circuit learning (DDCL) for generative modeling trains a parameterized circuit ansatz to prepare a target distribution. There are many different loss functions that can be utilized in training, and the optimization can be gradient-based or gradient-free. Recent studies have used: clipped log-likelihoods [3], the Jensen-Shannon divergence [11], the Stein divergence [12]. Following the work of Ref [4] and our earlier studies [5] we use the maximum mean discrepancy (MMD) loss function with radial basis function kernels ($\sigma = 0.1$) and gradient-based optimization with Adam [6] using code adapted from [13]. The circuit gradient is evaluated using the parameter shift rule [4, 9, 14]. The parameter shift rule defines an exact expression for the circuit gradient, but device noise and sampling noise reduce any gradient evaluation on hardware to an estimation. Now with the addition of error mitigation this noisy estimate can be distorted due to the amplitude of a state in the mitigated distribution becoming zero.

All target distributions are mapped onto the 16 computational basis states of a 4 qubit circuit. In Sections III and IV the target distribution is the Bars and Stripes benchmark distribution (Figure 4) (top panel), which was recently shown to be difficult to prepare on a quantum device due to its high entanglement entropy [3]. In Section V we expand our study to a set of non-uniform distributions (Figure 4 middle, bottom panels).

There are many loss functions used in training generative models [15, 16] and a growing number of performance metrics [3, 5] to evaluate the performance of DDCL. We use the Kullback-Leibler(KL) divergence,

$$D(p|q') = \sum_i p(x_i) \log \left(\frac{p(x_i)}{q'(x_i)} \right), \quad (1)$$

to quantify the distance between a target distribution $p(\mathbf{x})$ and a measured one $q'(\mathbf{x})$ and thus as a metric for performance of a QCBM. The distributions $q'(\mathbf{x})$ may be mitigated by non-trivial AEM ($\mathbb{K}_{hw,circ}$) or by the identity matrix ($\mathbb{K}_{\mathbb{1}}$).

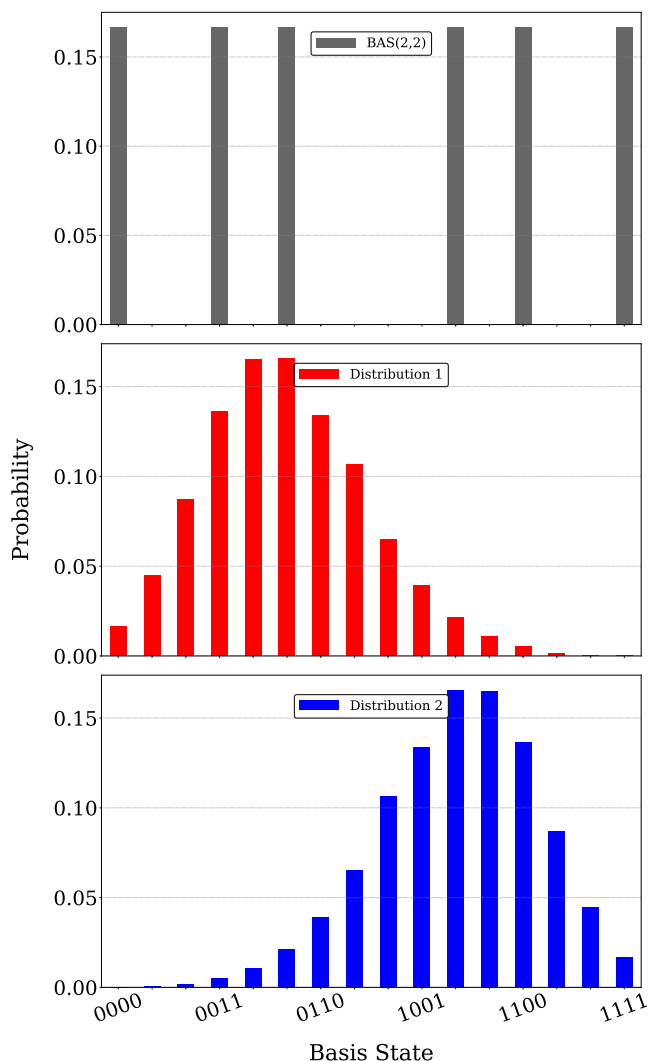


FIG. 4. 3 target distributions $p(\mathbf{x})$ mapped onto the $2^4 = 16$ basis states of a 4-qubit circuit: (Top) discrete Bars and Stripes distribution (Middle) Distribution 1 is a discretized Poisson distribution, (Right) Distribution 2 is constructed from Distribution 1 by applying `numpy.fliplr()`.

The KL metric diverges if $q'(x_i) = 0$ where $p(x_i) \neq 0$, but it is commonly used in the literature and allows us to compare our QCBM performance to other contemporary studies [3, 4, 11]. To avoid the shortcoming of the KL metric, in training we use \mathcal{L}_{MMD} as a cost function. When $q'(\mathbf{x}) = p(\mathbf{x})$ both KL metric and \mathcal{L}_{MMD} vanish and multiple studies [3, 5] show that optimizing a separate loss function yields good performance in minimizing the KL metric divergence. This allows us the freedom to study how incorporating error mitigation in different parts of the DDCL workflow affect the overall QCBM performance.

TABLE I. $\min \langle D(P|Q) \rangle$ values observed in post-processed data for circuits trained on `ibmq_20_tokyo` sub-sampled with 2048 shots.

Circuit	Layout	$\mathbb{1}$ (post)	\mathbb{K}_{hw} (post)	\mathbb{K}_{circ} (post)
$d_C = 2$	PA	0.3333	0.1761	0.1509
$d_C = 2$	PB	0.2602	0.0988	0.0763
$d_C = 3$	T1	0.4814	0.3142	0.2051
$d_C = 3$	PB	0.5390	0.4069	0.3750

III. ERROR MITIGATION IN METRIC EVALUATION

Here we present an initial study of how the assignment error matrix can be used as a post-processing technique to improve a given performance metric. The $d_C = 2, 3$ circuit classes were used to construct several QCBMs that were trained on the 20-qubit Tokyo superconducting qubit system (`ibmq_20_tokyo`) via gradient-based DDCL training [4, 5] for a fixed number (25) of Adam steps. The circuit parameters $\{\theta\}$ are initialized with the same set of random starting values $\{\theta_i\}$ and during training the shot size is fixed at 2048. The AEM were generated May 8–17 2019, the trained circuit parameters $\{\theta_f\}$ were obtained on `ibmq_20_tokyo` May 19–25 2019, and the un-mitigated distributions were generated May 21–25 2019.

The circuit parameters recorded during training are used to generate multiple distributions at each step. For each set of parameters, a batch of 5 identical circuits were sent to the hardware and evaluated with 2048 shots. These counts were used to construct a composite distribution with an effective shot size of 10240.

To study the effect of hardware AEM (\mathbb{K}_{hw}), a mitigated distribution was generated from the composite distribution. From this mitigated composite distribution we then draw a set of sub-samples to re-evaluate and provide an error-mitigated KL metric. This procedure was repeated with the circuit AEM (\mathbb{K}_{circ}). The training, distribution evaluation, and generation of each \mathbb{K} are all done using the same hardware qubits.

We plot average KL metric values ($\langle D(P|Q) \rangle$) defined by resampling a composite distribution 10 times to show the reduction in $\langle D(P|Q) \rangle$ for single training runs at different hardware locations: in Figure 5 we show the results for $d_C = 2$ circuits and in Figure 6 we show the results for $d_C = 3$ circuits. We plot $\langle D(P|Q) \rangle$ values to show that the reduction in $\langle D(P|Q) \rangle$ due to EM falls outside of the variance due to statistical noise. Error mitigation does not result in a reduction of $\langle D(P|Q) \rangle$ for all parameters: at early training parameters, error mitigation can lead to an increase or even divergence of KL metric if the amplitude of a BAS state in the mitigated distribution becomes zero.

In Table I we summarize the lowest value $\langle D(P|Q) \rangle$ observed for the $d_C = 2$ and $d_C = 3$ circuits trained on `ibmq_20_tokyo` and post-processed with hardware- and circuit-based AEM.

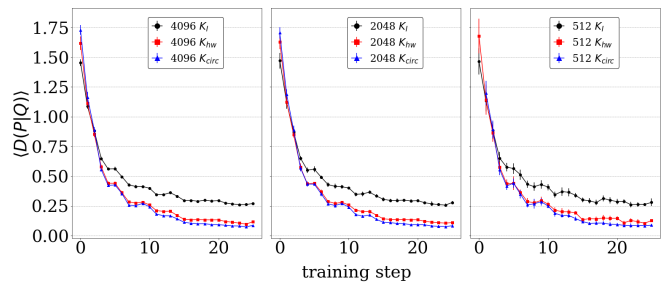


FIG. 5. $\langle D(P|Q) \rangle$ for $d_C = 2$ circuits at P_B , mitigated with: $\mathbb{1}$ (black, circles), \mathbb{K}_{hw} (red, square) and \mathbb{K}_{circ} (blue, diamonds). Sub-sampled with: (Left) 4096 shots, (Center) 2048 shots, (Right) 512 shots.

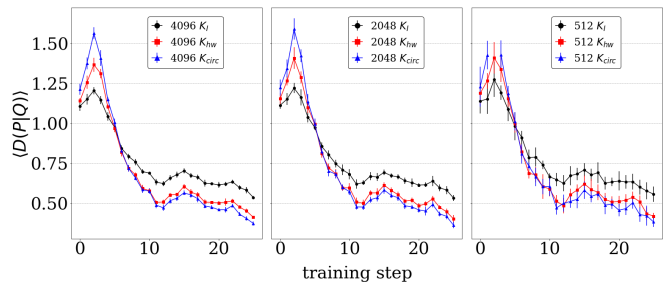


FIG. 6. $\langle D(P|Q) \rangle$ for $d_C = 3$ circuits at P_B , mitigated with: $\mathbb{1}$ (black, circles), \mathbb{K}_{hw} (red, square) and \mathbb{K}_{circ} (blue, diamonds). Sub-sampled with: (Left) 4096 shots, (Center) 2048 shots, (Right) 512 shots.

IV. ERROR MITIGATION IN GRADIENT TRAINING

In this section we examine the effects of EM at each step in gradient-based circuit training. The basic experiment remains the same as in Section III, except that rather than solely post-process the final distributions, we post-process at each training step and feed an error-mitigated loss function to the optimizer. The assignment error matrices are generated once at the start of training and used to mitigate the distributions evaluated throughout the training procedure. To study the effect of error mitigation on the gradient-based training dynamics, we focus on the optimization of the \mathcal{L}_{MMD} function used to train the circuits and use this as a metric for EM efficacy in training.

Queue times can lead to long time lags between AEM generation and when it is used in training, but the time between AEM generation and usage is shorter than in the previous section. On `ibmq_boeblingen`: AEMs, initial circuit parameters, and distributions trained and generated between September 18–19 2019 and the longest time period between AEM generation and distribution evaluation was 21h 34min. On `ibmq_valencia`: AEMs, initial circuit parameters, and distributions were trained and generated between September 13–15 2019 and the longest time period between AEM generation and distri-

TABLE II. $\min(\mathcal{L}_{MMD})$ observed in training $d_C = 3$ circuits on `ibmq_boeblingen` and `ibmq_valencia` with BAS(2,2) target.

QPU (Layout)	\mathbb{K}_{\perp} (train)	\mathbb{K}_{hw} (train)	\mathbb{K}_{circ} (train)
<code>ibmq_boeblingen</code> (T_0)	0.0214	0.00555	0.0178
<code>ibmq_boeblingen</code> (T_1)	0.0290	0.0122	0.0177
<code>ibmq_valencia</code>	0.0273	0.0136	0.0110
<code>ibmq_valencia</code> (pre-trained)	0.0174	0.00799	0.00644

bution evaluation was 16h 14min. AEM were generated daily and the shortest time between AEM generation and final distribution evaluation for either `ibmq_boeblingen` or `ibmq_valencia` was less than 75 minutes.

We trained the $d_C = 3$ circuit for a fixed number of steps on different QPU available from IBM: `ibmq_boeblingen` accessed via a cloud-based queue and `ibmq_valencia` accessed via a cloud-based reservation system. It was verified that the compiled QASM circuit executed on each QPU used the minimum number of CNOT gates. On `ibmq_boeblingen` we trained each circuit for 20 steps of Adam at two locations (T_0, T_1). On `ibmq_valencia` we ran 2 training sets: the first trained the circuit for 15 steps of Adam starting from a random initialization; the second trained the circuit for 7 steps of Adam starting from initial parameters that were pre-trained on `ibmq_20_tokyo`. In Figures 7 and 9 we show \mathcal{L}_{MMD} evaluated during training using mitigated distributions and report the minimum MMD loss value measured during training in Table II. For this pre-trained circuit we reduced the learning rate to $\alpha = 0.1$.

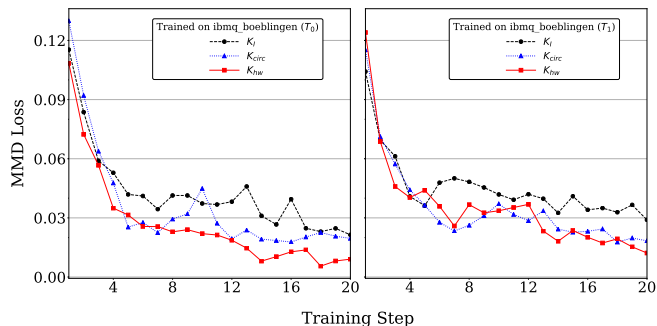


FIG. 7. \mathcal{L}_{MMD} for a $d_C = 3$ circuit during 20 steps of training with Adam on `ibmq_boeblingen` and 3 AEM in training. (Left) Measured on T_0 for \mathbb{K}_{\perp} (black, circles, dotted), \mathbb{K}_{hw} (red, squares, solid) and \mathbb{K}_{circ} (blue, triangles, dashed). (Right) Measured on T_1 for \mathbb{K}_{\perp} (black, circles, dotted), \mathbb{K}_{hw} (red, squares, solid) and \mathbb{K}_{circ} (blue, triangles, dashed).

The circuit parameters recorded during training are used to generate multiple distributions at each step. For each set of parameters evaluated on `ibmq_boeblingen`, a batch of 5 identical circuits were sent to the hardware

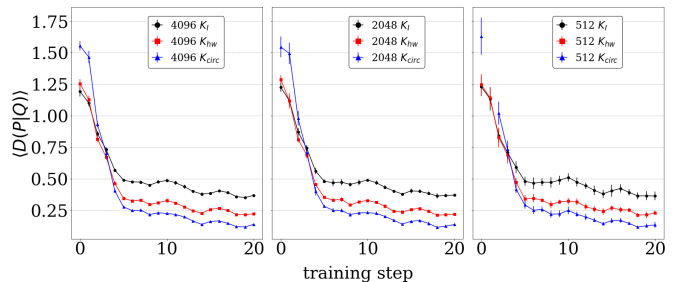


FIG. 8. $\langle D(P|Q) \rangle$ for $d_C = 3$ circuits trained with \mathbb{K}_{hw} in training on `ibmq_boeblingen` at T_0 , sub-sampled with: (Left) 4096 shots, (Center) 2048 shots, (Right) 512 shots. The scores are post-processed with: \mathbb{K}_{\perp} (black, circles), \mathbb{K}_{hw} (red, square) and \mathbb{K}_{circ} (blue, triangles).

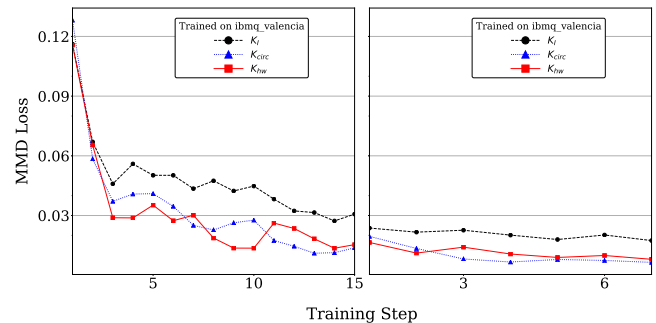


FIG. 9. \mathcal{L}_{MMD} for a $d_C = 3$ circuit measured during training with Adam on `ibmq_valencia` and 3 AEM in training. (Left) 15 steps of Adam training with \mathbb{K}_{\perp} (black, circles, dotted), \mathbb{K}_{hw} (red, squares, solid) and \mathbb{K}_{circ} (blue, triangles, dashed). (Right) 7 steps of Adam from pre-trained values with \mathbb{K}_{\perp} (black, circles, dotted), \mathbb{K}_{hw} (red, squares, solid) and \mathbb{K}_{circ} (blue, triangles, dashed).

and evaluated with 2048 shots to construct a composite distribution with effective shot size of 10240. For each set of parameters evaluated on `ibmq_valencia`, a batch of 2 identical circuits were sent to the hardware and evaluated with 8192 shots. These counts were used to construct a composite distribution with an effective shot size of 16384. When evaluating the KL metric we apply post-processing as in Section III. In Figure 8 we plot $\langle D(P|Q) \rangle$ for the circuit trained at T_0 with \mathbb{K}_{hw} . This circuit had the lowest MMD values in training (see Figure 9) and the reduction in $\langle D(P|Q) \rangle$ at later training steps is again far outside the variance induced by statistical noise. We report the minimum score values observed over the training data for all circuits in Table III.

V. DISCUSSION

Densely parameterized quantum circuits (circuits where the dimension of the gradient far exceeds the size of the qubit register) pose an interesting challenge to the problem of SPAM error mitigation. We rely on the AEM

TABLE III. $\min \langle D(P|Q) \rangle$ values observed in post-processed data for $d_C = 3$ circuits trained on `ibmq_boeblingen` and `ibmq_valencia`. Mean taken from 10 distributions subsampled with 2048 shots.

QPU (Layout)	AEM (train)	$\mathbb{K}_{\mathbb{1}}$ (post)	\mathbb{K}_{hw} (post)	\mathbb{K}_{circ} (post)
<code>ibmq_boeblingen</code> (T_0)	$\mathbb{K}_{\mathbb{1}}$	0.3199	0.1827	0.1135
<code>ibmq_boeblingen</code> (T_1)	$\mathbb{K}_{\mathbb{1}}$	0.3701	0.2593	0.2426
<code>ibmq_boeblingen</code> (T_0)	\mathbb{K}_{hw}	0.3601	0.2169	0.1205
<code>ibmq_boeblingen</code> (T_1)	\mathbb{K}_{hw}	0.3345	0.2083	0.1950
<code>ibmq_boeblingen</code> (T_0)	\mathbb{K}_{circ}	0.4371	0.2831	0.2170
<code>ibmq_boeblingen</code> (T_1)	\mathbb{K}_{circ}	0.4060	0.2935	0.2808
<code>ibmq_valencia</code>	$\mathbb{K}_{\mathbb{1}}$	0.3726	0.2170	0.1776
<code>ibmq_valencia</code> (pre-trained)	$\mathbb{K}_{\mathbb{1}}$	0.2938	0.1196	0.0869
<code>ibmq_valencia</code>	\mathbb{K}_{hw}	0.3243	0.1668	0.1374
<code>ibmq_valencia</code> (pre-trained)	\mathbb{K}_{hw}	0.2920	0.1261	0.0888
<code>ibmq_valencia</code>	\mathbb{K}_{circ}	0.3560	0.2090	0.1770
<code>ibmq_valencia</code> (pre-trained)	\mathbb{K}_{circ}	0.3115	0.1498	0.1133

to mitigate assignment errors (using \mathbb{K}_{hw}) and also general circuit noise (using \mathbb{K}_{circ}). Our first point of discussion is how robust the post-processing is to the temporal characteristics of the hardware as captured by the AEM. Our second point of discussion is how error mitigation in training is affected by the target distribution.

A. Temporal robustness of metric post-processing

Our approach to error mitigation relies on a matrix characterization of hardware noise. We do not attempt to characterize the noise of individual gates but instead gives an approximation of how SPAM errors manifest in preparing the individual basis states. In Section III we showed that AEM kernels that were not generated at training time could be used to post-process distributions and obtain improved KL metric performance. This points to low hardware drift of qualitative noise properties over time. In Section IV, when using error mitigation in our circuit training, the AEMs were generated at the start of training. We access these quantum devices remotely it may not be feasible to evaluate the AEM exactly at the time of training; for the case of long queue times the training steps can occur at significant time lags after generating a specific AEM. Since it is known that the noise characteristics of quantum devices are time dependent, it is important to analyze the robustness of our approach to error mitigation with respect to time.

In the absence of any noise or error, $\mathbb{K}_{kernel} = \mathbb{1}$ and

TABLE IV. Frobenius norm $\|(\mathbb{1} - \mathbb{K}_{hw})\|$ for AEM generated on `ibmq_20_tokyo`.

Date	P_A	P_B	T_1
07/25/2019	1.142	0.888	1.250
07/30/2019	1.110	1.001	1.176
07/31/2019	0.935	0.990	1.082
08/03/2019	1.121	0.936	1.084
08/04/2019	1.047	0.961	1.026
08/06/2019	0.899	0.842	1.051
08/07/2019	0.807	0.804	1.017
08/08/2019	0.866	0.833	1.047

TABLE V. Frobenius norm $\|(\mathbb{1} - \mathbb{K}_{circ})\|$ for AEM generated on `ibmq_20_tokyo`.

Date	$d_C = 2$ (P_A)	$d_C = 2$ (P_B)	$d_C = 3$ (P_B)	$d_C = 3$ (T_1)
07/25/2019	1.338	1.208	1.253	1.487
07/30/2019	1.299	1.151	1.281	1.516
07/31/2019	1.193	1.187	1.305	1.499
08/03/2019	1.159	1.272	1.218	1.594
08/04/2019	1.140	1.204	1.358	1.436
08/06/2019	1.559	1.105	1.194	1.546
08/07/2019	1.032	1.053	1.120	1.264
08/08/2019	1.132	1.087	1.186	1.385

any basis state will be prepared with fidelity 1.0. To quantify the degree of “noisiness” in AEMs we calculate the distance between (\mathbb{K}_{kernel}) and the identity matrix using the Frobenius norm of $(\mathbb{1} - \mathbb{K}_{kernel})$:

$$\|(\mathbb{1} - \mathbb{K}_{kernel})\| = \sqrt{\sum_i \sum_j |(\delta_{ij} - \mathbb{K}_{kernel}(i, j))|^2}. \quad (2)$$

In Table IV we report the individual norms of $\mathbb{1} - \mathbb{K}_{hw}$ and in Table V we report the individual norms of $\mathbb{1} - \mathbb{K}_{circ}$ for multiple AEM that were generated over a 2 week span. For \mathbb{K}_{hw} , the norms have range [0.803, 1.25] and norms for \mathbb{K}_{circ} generated over the same 2 week span have range [1.03, 1.59]. Fluctuations in hardware noise leads to significant differences between AEMs generated on different dates.

For reference, the Frobenius norm of $\|(\mathbb{1} - \mathbb{K}_{hw})\|$ for AEM generated on `ibmq_20_tokyo` in May 2019 is 0.792 (P_A), 0.836 (P_B), and 0.923 (T_1). The Frobenius norm of $\|(\mathbb{1} - \mathbb{K}_{circ})\|$ for AEM generated on `ibmq_20_tokyo` in May 2019 is 1.746 ($d_C = 2$, P_A), 1.185 ($d_C = 2$, P_B), 1.207 ($d_C = 3$, P_B) and 1.425 ($d_C = 3$, T_1). The post-processed KL metric values are reported in Table I, overall the \mathbb{K}_{circ} led to the largest reductions in $\min \langle D(P|Q) \rangle$. For $d_C = 2$ circuits the KL metric was reduced by 54.7% (at P_A) and 70.6% (at P_B). For $d_C = 3$ circuits the KL metric was reduced by 57.4% (at T_1), and 30.4% (at P_B).

Using the set of AEMs generated in July–August 2019, we re-ran the post-processing methods of Section III on circuits trained on `ibmq_20_tokyo` and plot the values

in Figures 10 and 11. When these AEMs are used to post-process the same data as in Section III, we see similar reductions in the KL metric. Again the \mathbb{K}_{circ} again gave maximum reductions in the $\min \langle D(P|Q) \rangle$ value. For $d_C = 2$ circuits the maximum reduction in the KL metric was 63.5% at P_A and 82.6% at P_B . For the $d_C = 3$ circuits the maximum reduction in the KL metric value was 62.7% at T_1 and 33.8% at P_B .

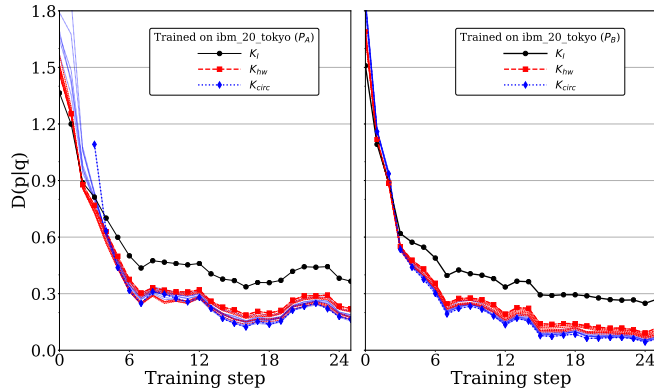


FIG. 10. $D(P|Q)$ values for $d_C = 2$ circuits trained on `ibmq_20_tokyo` in May 2019, sampled at 2048 shots, and post-processed with the \mathbb{K}_{hw} (red, dashed) and \mathbb{K}_{circ} (blue, dotted) summarized in Tables IV and V. Un-mitigated values (black, circles, solid) show as a reference. (Left) Circuits deployed on P_A , (Right) Circuits deployed on P_B .

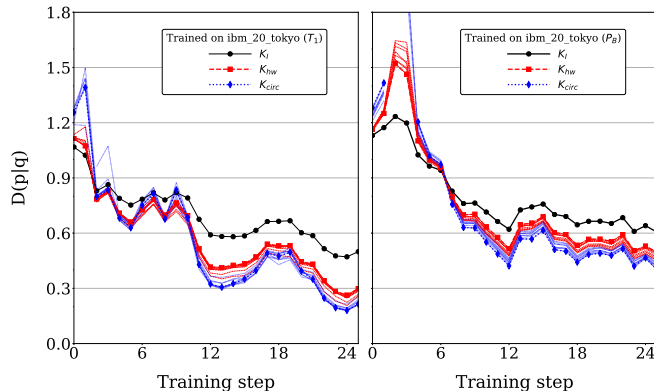


FIG. 11. $D(P|Q)$ values for $d_C = 3$ circuits trained on `ibmq_20_tokyo` in May 2019, sampled at 2048 shots, and post-processed with the 8 \mathbb{K}_{hw} (red, dashed) and 8 \mathbb{K}_{circ} (blue, dotted) summarized in Tables IV and V. Un-processed values (black, circles, solid) show as a reference. (Left) Circuits deployed on (T_1) , (Right) circuits deployed on (P_B) .

The $BAS(2,2)$ distribution (Figure 4) should be difficult to prepare due to its high entanglement entropy [3], but in order to test if something specific about this target distribution makes EM in post-processing particularly effective, we expanded the benchmark with additional experiments test for edge cases. For example, after several steps of training the amplitudes of the BAS

states are greater than the non- BAS states; this distribution can be “corrected” using a simple threshold function, $f(x) = \Theta(p(x) - p_0)$. Applying $f(x)$ to the final sampled state of a circuit would suppress states with probabilities $p(x) < p_0$. If the amplitude of all BAS states are above the threshold value then only non- BAS states are removed and the KL score will improve with no assumption about the state being spurious or not. To test if our EM method is oversimplifying the distribution in the manner outlined above, we applied it to other distributions for which $f(x)$ would fail at improving fidelity to the target distribution, which we outline in the next section.

B. Robustness of gradient-based training

When error mitigation (see Section II) is incorporated into gradient-based training the classical optimizer updates the circuit parameters from information in the mitigated loss gradient. Post-processing discards counts (i.e. information) from the final sampled state that is assumed to be spurious, however we need to ensure that information relevant to state learning is not lost.

In Sections III and IV all circuits were trained with the $BAS(2,2)$ distribution as a target. The results presented in Section III show that using mitigated distributions to evaluate the KL metric can improve performance over un-mitigated distributions, but in Section V A we conjectured that the improvements in the KL metric and the robustness of the metric post-processing might be due to EM simply discarding low amplitude states indiscriminately (which would be deleterious to the metric for more complex distributions that contain eigenstates with low probability amplitudes). If that was the case, then this would be reflected in the training dynamics and specifically in the optimization of the MMD loss function. Yet in Section IV we observe that the MMD values recorded during training show that the circuits with AEM mitigation tend to reach lower loss values compared to the non-mitigated \mathbb{K}_1 circuits (see Figures 7 and 9).

To further explore the effects of error mitigation in training, we repeated the same experiments in Section IV on `ibmq_valencia` using a second set of distributions, shown in Figure 4. In contrast to the $BAS(2,2)$ distribution (Figure 4), training a circuit to fit these new distributions requires that low-amplitude states are learned and not discarded. The highest weight state $|1111\rangle$ has zero amplitude in Distribution 1 and the lowest weight state $|0000\rangle$ has zero amplitude in Distribution 2. The smallest non-zero amplitude in each distribution was $p(x_i) = 0.0005$ and training circuits using 2048 shots gives sufficient resolution.

It would be difficult to learn the target distribution with high accuracy at this shot size, but our goal was to observe qualitative behavior of the AEM in training. In Table VI we summarize the lowest MMD values measured during training and in Table VII we summarize the lowest $\langle D(P|Q) \rangle$ scores found using post-processing. Comparing

TABLE VI. $\min(\mathcal{L}_{MMD})$ values observed in training on `ibmq_valencia`.

Target	\mathbb{K}_{\perp} (train)	\mathbb{K}_{hw} (train)	\mathbb{K}_{circ} (train)
Distribution 1	0.0133	0.00826	0.00741
Distribution 2	0.00778	0.00591	0.00535

TABLE VII. $\min\langle D(P|Q)\rangle$ values observed in post-processed data for $d_C = 3$ circuits trained on `ibmq_valencia`. Mean taken from 10 distributions sub-sampled with 2048 shots.

Target	AEM (train)	\mathbb{K}_{\perp} (post)	\mathbb{K}_{hw} (post)	\mathbb{K}_{circ} (post)
Distribution 1	\mathbb{K}_{\perp}	0.1481	0.1174	0.1724
Distribution 1	\mathbb{K}_{hw}	0.1423	0.1088	0.1229
Distribution 1	\mathbb{K}_{circ}	0.1200	0.1190	0.2783
Distribution 2	\mathbb{K}_{\perp}	0.1807	0.1954	0.2093
Distribution 2	\mathbb{K}_{hw}	0.1230	0.1049	0.1013
Distribution 2	\mathbb{K}_{circ}	0.1215	0.0923	0.0883

the MMD values from Table VI to the KL metric values with \mathbb{K}_{\perp} in post we see that the inclusion of EM in training led to lower values of both the MMD loss and KL metric. However the inclusion of EM in post-processing led to interesting behavior.

In Section III we observed that post-processing with \mathbb{K}_{circ} returned the lowest KL metric values for the BAS(2,2) distribution, and in Section IV circuits with EM in training and EM in post-processing had lower KL metric values. In Table VII we observe that the circuit with \mathbb{K}_{circ} in training and \mathbb{K}_{circ} in post-processing increased the KL metric value; whereas the circuit trained with \mathbb{K}_{hw} in training and \mathbb{K}_{hw} in post-processing returned the lowest KL metric value. Since Distributions 1 and 2 contain very low amplitude states we re-evaluated the KL metric values with a high shot size (Table VIII), yet the qualitative behavior remained the same. For these target distributions post-processing frequently causes the low-amplitude states to have zero amplitude in the mitigated distribution and the KL metric is infinite at several training steps.

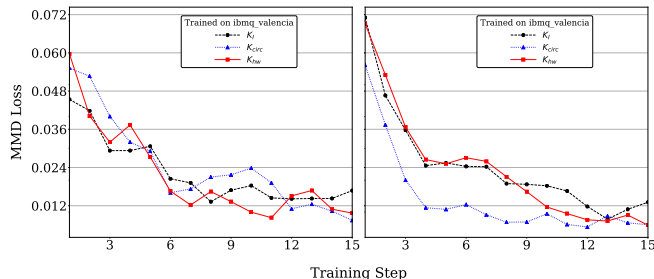


FIG. 12. \mathcal{L}_{MMD} measured on `ibmq_valencia` during 15 steps of training with Adam using 3 AEM in training: \mathbb{K}_{\perp} (black, circles, dotted), \mathbb{K}_{hw} (red, squares, solid) and \mathbb{K}_{circ} (blue, diamonds, dashed). (Left) Target is Distribution 1 (right) Target is Distribution 2.

TABLE VIII. $\min\langle D(P|Q)\rangle$ values observed in post-processed data for $d_C = 3$ circuits trained on `ibmq_valencia`. Mean taken from 10 distributions sub-sampled with 4096 shots.

Target	AEM (train)	\mathbb{K}_{\perp} (post)	\mathbb{K}_{hw} (post)	\mathbb{K}_{circ} (post)
Distribution 1	\mathbb{K}_{\perp}	0.1427	0.1175	0.1698
Distribution 1	\mathbb{K}_{hw}	0.1372	0.1085	0.1211
Distribution 1	\mathbb{K}_{circ}	0.1169	0.1264	0.1747
Distribution 2	\mathbb{K}_{\perp}	0.1836	0.1962	0.1960
Distribution 2	\mathbb{K}_{hw}	0.1246	0.1074	0.0988
Distribution 2	\mathbb{K}_{circ}	0.1170	0.0953	0.0856

In Section IV we can observe qualitative effects of incorporating error mitigation from the overall behavior of the MMD loss function during training. If the error mitigation step was arbitrarily discarding low count states then we would expect to see a severe reduction in the MMD minimization. While the addition of error mitigation inside the gradient-based training does not appear to result in catastrophic loss of information there are some subtle effects with different target distributions. With the Bars and Stripes target, the inclusion of error mitigation inside the gradient-based training led to lower MMD values earlier in training for most circuits- the only exception was the circuit trained on `ibmq_boeblingen` with \mathbb{K}_{circ} at T_0 (see Figure 7). When the same circuit ansatz was trained on `ibmq_valencia` the non-trivial AEM resulted in lower MMD values. When we trained QCBMs with respect to non-uniform distributions we notice that overall the lowest MMD values are observed when non-trivial AEMs are used in training. While a significant speedup in training may be observed, (as seen in Figure 12 for \mathbb{K}_{circ} and Distribution 2) the training dynamics with the trivial AEM can also be very similar to the training dynamics with non-trivial AEM (as seen in Figure 12 for Distribution 1). These results are promising but suggest that the performance of DDCL is dependent on the choice of optimizer, target distribution. Combined with the AEM asymmetry means a more in-depth study is needed to investigate the efficacy of error mitigation for gradient-based training.

VI. CONCLUSIONS

In this work we consider two challenges faced when training parameterized circuits on NISQ devices: how to effectively optimize the parameters of a circuit in the presence of noisy sampling, and how to extract a baseline measure of metrics from noisy evaluations. Observations made in previous studies, such as the need to optimize circuit design for sparsity and hardware layout, still play a significant role even with the addition of error mitigation. The KL metric gives us the final circuit performance and we use this to explore the efficacy of error mitigation in post-processing.

Without any error mitigation in either the gradient-based training, or the evaluation of the Kullback-Leibler metric, the lowest KL metric value we observed for QCBMs trained for 25 steps of Adam on noisy hardware was 0.2602. This was observed for the sparsest circuit class $d_C = 2$ optimized to run on `ibmq_20_tokyo`. A recent study of QCBM training on Rigetti hardware have reported Kullback-Leibler values for trained QCBMs on the order of 0.1 [11]. We set a threshold on the Kullback-Leibler metric of $\langle D(p|q) \rangle < 0.1$ then we find that with error mitigation, two circuits can reach this threshold for the BAS(2,2) distribution. The $d_C = 2$ circuit trained on `ibmq_20_tokyo` reached this threshold with error mitigation in metric post-processing ($\langle D(p|q) \rangle = 0.0763$), and the $d_C = 3$ circuit trained on `ibmq_valencia` with error mitigation in training and also post-processing ($\langle D(p|q) \rangle = 0.0832$ with random initialization, $\langle D(p|q) \rangle = 0.0888$ with pre-training). For the second set of distributions, the $d_C = 3$ circuit was able to surpass this threshold for Distribution 2 ($\langle D(p|q) \rangle = 0.0883$). In Section III post-processing a measured distribution with an AEM reduced the value of the KL metric divergence by reducing the amplitude of states that are assumed to be spurious (the result of assignment error). However this assumption can cause divergence of the KL metric which was observed for the Bars and Stripes distribution at parameters saved early in training, where it is possible for a BAS state to have low amplitude, and in general for target distributions that contains low amplitude states (Distribution 1, 2).

The performance of the MMD loss function over multiple training runs with EM included shows that EM typically causes a decrease in loss function at earlier training steps, as in Fig. 12 for Distribution 2, and in Figs. 7 and 9 for the BAS distribution. This means that EM can decrease training time. Thus, a usable metric when studying loss functions with EM in training would be

time to convergence, or resources required to achieve the minimal value. In several cases, we observe that training with EM qualitatively improves this metric.

In this work we studied how to benchmark the efficacy of gradient-based optimization in the presence of device noise with the addition of matrix-based method error mitigation. The training of parametrized circuits is a complex computational task that is dependent on the circuit ansatz, target distribution, classical optimization method and the time-dependence of device noise. Nonetheless we have observed benefits to using matrix-based error mitigation. In the future, the benchmark will be improved to include additional distributions, and as pulse-level controls become available to the general user, lower level circuit designs. The mitigation of hardware noise is also a complex problem and it may be necessary to supplement AEM with other error mitigation techniques (e.g. Richardson extrapolation [2, 8, 9], probabilistic cancellation [8], pulse stretching [17] or modified circuits [18]).

VII. ACKNOWLEDGEMENTS

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Appendix A: Mitigation SWAP gate noise

The motivation behind the design of circuit-specific assignment error matrices is to attempt to capture additional noise and errors outside of the measurement error. In Sections III to V we saw that using the circuit-

specific AEM to post-process a measured distribution led to lower values of the Kullback-Leibler metric compared to the more general, hardware AEM and lower MMD values during training.

In the main text we discussed circuits with sparse entangling layers, trained on hardware with connectivity that supports the gate layout. The $d_C = 3$ circuit was trained on 3 qubit devices (`ibmq_boeblingen`, `ibmq_valencia`, `ibmq_tokyo`) but the $d_C = 2$ circuit was only trained on `ibmq_tokyo`. The sparsity of the entangler layers and the optimization with hardware layout is designed to reduce the overall amount of two-qubit gate noise by reducing the number of noisy gates in a compiled circuit. The compiled circuits executed on hardware in the main text had the minimum number of CNOTs (4 and 6, for $d_C = 2$ and $d_C = 3$ respectively).

If a circuit is executed on hardware that does not exactly match the hardware coupler layout, then additional CNOTs will be added to the compiled circuit. We tested the efficacy of error mitigation for noise associated with added CNOTs by running the same experiments from Section IV using a $d_C = 2$ circuit on `ibmq_boeblingen`. On `ibmq_tokyo` the compiled circuit contained only 4 CNOT gates, but on `ibmq_boeblingen` the compiled circuit could have up to 16 CNOT gates.

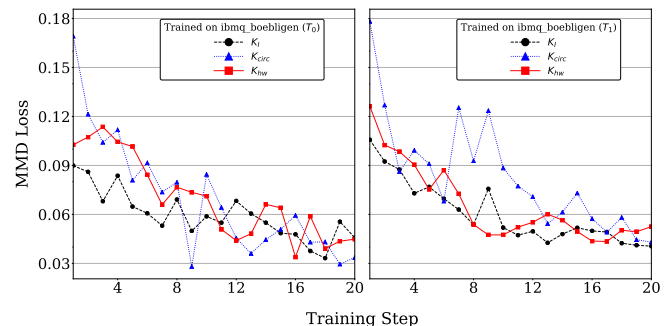


FIG. 13. \mathcal{L}_{MMD} for a $d_C = 2$ circuit during 20 steps of training with Adam on `ibmq_boeblingen` and 3 AEM in training. (Left) Measured on T_0 for \mathbb{K}_{\perp} (black, circles, dotted), \mathbb{K}_{hw} (red, squares, solid) and \mathbb{K}_{circ} (blue, diamonds, dashed). (Right) Measured on T_1 for \mathbb{K}_{\perp} (black, circles, dotted), \mathbb{K}_{hw} (red, squares, solid) and \mathbb{K}_{circ} (blue, diamonds, dashed).

Now, circuits trained with \mathbb{K}_{hw} or \mathbb{K}_{circ} in training shows no substantial improvement in the MMD loss minimization, and in Figure 13 we see that the inclusion of EM in training can impair the minimization of MMD over training. The $\min(\mathcal{L}_{MMD})$ measured was 0.0332, 0.033, and 0.0281 for \perp, \mathbb{K}_{hw} and \mathbb{K}_{circ} , respectively. Yet post-processing did show improvement in the Kullback-Leibler metric (reported in Table IX). In the main text we observed a lowest value of $\min\langle D(P|Q) \rangle = 0.0763$ for a $d_C = 2$ circuit trained on `ibmq_tokyo`. Now on `ibmq_boeblingen` with additional CNOTs the lowest value of $\min\langle D(P|Q) \rangle = 0.1490$.

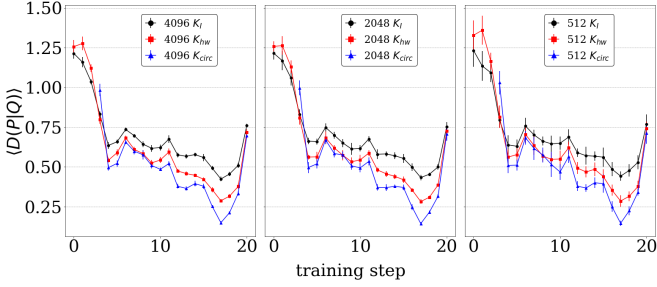


FIG. 14. $\langle D(P|Q) \rangle$ for $d_C = 2$ circuits with identity-AEM in training on `ibmq_boeblingen` random initialization. Averaged over 10 sub-samples of (Left) 4096 shots, (Center) 2048 shots, (Right) 512 shots. The scores are post-processed with: no error mitigation (black, circles), hardware-AEM mitigation (red, square) and circuit-AEM mitigation (blue, diamonds).

TABLE IX. $\min \langle D(P|Q) \rangle$ values observed in post-processed data for $d_C = 2$ circuits trained on `ibmq_boeblingen`. Mean taken from 10 sub-sampled distributions of 2048 shots.

QPU (Layout)	AEM (train)	$\mathbb{1}$ (post)	\mathbb{K}_{hw} (post)	\mathbb{K}_{circ} (post)
<code>ibmq_boeblingen</code> (T_0)	$\mathbb{1}$	0.4373	0.2807	0.1490
<code>ibmq_boeblingen</code> (T_0)	\mathbb{K}_{hw}	0.5735	0.4779	0.3920
<code>ibmq_boeblingen</code> (T_0)	\mathbb{K}_{circ}	0.5967	0.5042	0.3990
<code>ibmq_boeblingen</code> (T_1)	$\mathbb{1}$	0.4632	0.4022	0.2552
<code>ibmq_boeblingen</code> (T_1)	\mathbb{K}_{hw}	0.5827	0.5154	0.4314
<code>ibmq_boeblingen</code> (T_1)	\mathbb{K}_{circ}	0.6649	0.6097	0.5124

Appendix B: Assignment error matrix construction

Our approach to error mitigation is based on the concept of assignment error matrices and we extract the error correlations from the output of multi-qubit circuits executed on localized qubit subsets. For a system of N qubits, a set of 2^N quantum circuits is used to prepare each individual state of the computational basis. The general hardware-AEM only mitigates readout errors and is generated using shallow circuits of N qubits and up to N individual X gates. We extend this AEM concept to a more general structure so we can estimate the general error associated with a particular parameterized circuit.

To construct the circuit-AEM we use the parameterized circuit ansatz shown in Figure 1 to prepare the 2^N basis states.

Since we project the final state prepared by the circuit onto a set of real-valued amplitudes there are multiple sets of rotational parameters that will result in the same final distribution. We constructed the matrices \mathbb{K}_{circ} used in the main text using the general circuit ansatz of Figure 1. The rotational parameters in the first and final ro-

TABLE X. Individual state fidelities for $d_C = 2$, $d_C = 3$ \mathbb{K}_{circ} and \mathbb{K}_{hw} all evaluated at P_B on `ibmq_20.tokyo`.

State	$\mathbb{K}_{circ, d_C = 2}$	$\mathbb{K}_{circ, d_C = 3}$	\mathbb{K}_{hw}
0000	0.8550	0.8379	0.9360
0001	0.7988	0.7935	0.8774
0010	0.7932	0.7773	0.8647
0011	0.7378	0.7422	0.8174
0100	0.7415	0.7136	0.8108
0101	0.7046	0.6943	0.7739
0110	0.6946	0.6846	0.7542
0111	0.6450	0.6504	0.7209
1000	0.8101	0.8115	0.8975
1001	0.7783	0.7764	0.8486
1010	0.7561	0.7500	0.8215
1011	0.7332	0.7251	0.7812
1100	0.7129	0.6858	0.7644
1101	0.6802	0.6812	0.7419
1110	0.7163	0.6667	0.7585

tation layers are all set to zero. Each qubit in the middle rotation layer has a gate sequence $R_X(\theta_i)R_Z(\theta_j)R_X(\theta_k)$ applied to it. By replacing this gate sequence with either $R_X(0)R_Z(0)R_X(0)$ or $R_X(-\pi/2)R_Z(-\pi)R_X(-\pi/2)$ we can use the parameterized ansatz to prepare any basis state. For example, applying $R_X(0)R_Z(0)R_X(0)$ to all 4 qubits will return only the state $|0000\rangle$ in the absence of noise.

When deployed on noisy hardware we can again construct an AEM that quantifies the probability of the target state being prepared, and the probabilities of other states being prepared. In Section V we calculated the Frobenius norm of the difference matrix $(\mathbb{1} - \mathbb{K})$ and showed that \mathbb{K}_{circ} matrices are much farther from the identity matrix than \mathbb{K}_{hw} matrices. The final AEM is assumed to be invertible and non-negative, but we note that the matrix is not symmetric. Additionally the individual state fidelities are not uniform. For 3 AEM generated on the same day on the same set of qubits we report the individual basis state fidelities in Table X.